

Effect of keysight 3458A jitter on precision of phase difference measurement

Pokatilov, Andrei; Kübarsepp, Toomas; Vabson, Viktor IEEE transactions on instrumentation and measurement 2016 / p. 2595-2600 : ill <https://doi.org/10.1109/TIM.2016.2593965> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)